Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/725,553	CHEN, OWEN	
Examiner	Art Unit	
Haissa Philogene	2828	

SEARCHED				
Class	Subclass	Date	Examiner	
315	307, 291, 225, 282	11/1/2005	HP 	
	209R			
	200R			
	212, 276			
	224, 289			
	Dig.7			
363	21.01-21.			
	26, 34			
	56.01-			
	56.07			
361	18, 35			
	38, 42		Y	
Updan	led	2/21/06	hp	
Search	950 Ve	(/	(

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
315	224, 291	2/21/2006	НР	
	225, 282		1	
	209R, Dig			
36/	18,38,42			
	s int. search printout	W		

SEARCH NOT (INCLUDING SEARCH	TES STRATEGY)
	DATE	EXMR
		
and the second of the second o		